

<b>Notice of References Cited</b>	Application/Control No. 10/576,338		Applicant(s)/Patent Under Reexamination BICH ET AL.	
	Examiner Henok Legesse		Art Unit 2861	Page 1 of 1

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*	B	US-6,286,927 B1	09-2001	Taneya et al.	347/19
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**NON-PATENT DOCUMENTS**

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